CHIP COIL (CHIP INDUCTORS) LQP02HQ□□□□02□ Reference Specification

1.Scope

This reference specification applies to LQP02HQ series, Chip coil (Chip Inductors).

2.Part Numbering

(ex) LQ P 02 H Q 0N4 W 0 2 L

Product ID Structure Dimension Applications Category Inductance Tolerance Features (L×W) and Electrode Packaging L:4mm-wide / plastic tape E:8mm-wide / plastic tape *B:Bulk

*Bulk packing also available. (A product is put in the plastic bag under the taping conditions.)

3.Rating

• Operating Temperature. -55°C to +125°C • Storage Temperature. -55°C to +125°C

 Storage Tempe 	erature. –55°C	to +125°	C		,	0 15 =		1
Customer Part Number	MURATA Part Number	Inductance		(GHz)		ency	Rated Current	
		(nH)	Tolerance	(min)	(Ω max)	*Typ.	Min.	(mA)
	LQP02HQ0N4W02L							
	LQP02HQ0N4W02E							
	LQP02HQ0N4B02L	0.4			0.03			
	LQP02HQ0N4B02E	0.4			0.03			
	LQP02HQ0N4C02L							
	LQP02HQ0N4C02E							1000
	LQP02HQ0N5W02L							1000
	LQP02HQ0N5W02E							
	LQP02HQ0N5B02L	0.5			0.04	>20	17.0	
	LQP02HQ0N5B02E	0.5			0.04	>20	17.0	
	LQP02HQ0N5C02L							
	LQP02HQ0N5C02E							
	LQP02HQ0N6W02L							
	LQP02HQ0N6W02E							
	LQP02HQ0N6B02L	0.6						050
	LQP02HQ0N6B02E							950
	LQP02HQ0N6C02L							
	LQP02HQ0N6C02E		W:±0.05nH					
	LQP02HQ0N7W02L						45.5	
	LQP02HQ0N7W02E	0.7						
	LQP02HQ0N7B02L		B:±0.1nH	14				
	LQP02HQ0N7B02E		0.7 C:±0.2nH					
	LQP02HQ0N7C02L							
	LQP02HQ0N7C02E							
	LQP02HQ0N8W02L					15.5		
	LQP02HQ0N8W02E					19		900
	LQP02HQ0N8B02L				0.05			
	LQP02HQ0N8B02E	8.0						
	LQP02HQ0N8C02L							
	LQP02HQ0N8C02E							
	LQP02HQ0N9W02L							
	LQP02HQ0N9W02E	0.9						
	LQP02HQ0N9B02L							
	LQP02HQ0N9B02E						14.6	
	LQP02HQ0N9C02L							
	LQP02HQ0N9C02E							
	LQP02HQ1N0W02L							
	LQP02HQ1N0W02E							
	LQP02HQ1N0B02L	1.0				18	13.2	
	LQP02HQ1N0B02E							

Customer Part Number	MURATA Part Number	Ind	uctance	Q (min)	DC Resistance	Self Res Frequ (GH	ency	Rated Current
		(nH)	Tolerance	(111111)	(Ω max)	*Typ.	Min.	(mA)
	LQP02HQ1N0C02L	1.0			0.05	18	13.2	900
	LQP02HQ1N0C02E				0.00			
	LQP02HQ1N1W02L							
	LQP02HQ1N1W02E							
_	LQP02HQ1N1B02L	1.1				16		850
_	LQP02HQ1N1B02E							
_	LQP02HQ1N1C02L							
	LQP02HQ1N1C02E				0.06		12.8	
	LQP02HQ1N2W02L							
	LQP02HQ1N2W02E							
	LQP02HQ1N2B02L	1.2						800
	LQP02HQ1N2B02E							
	LQP02HQ1N2C02L							
	LQP02HQ1N2C02E					15		
	LQP02HQ1N3W02L		W:±0.05nH					
	LQP02HQ1N3W02E	-	B:±0.1nH					
	LQP02HQ1N3B02L	1.3	C:±0.2nH					
	LQP02HQ1N3B02E							
	LQP02HQ1N3C02L							
	LQP02HQ1N3C02E							
	LQP02HQ1N4W02L							
	LQP02HQ1N4W02E							
	LQP02HQ1N4B02L	1.4				14.5	12.7	
	LQP02HQ1N4B02E							
	LQP02HQ1N4C02L							
	LQP02HQ1N4C02E							
	LQP02HQ1N5W02L							
	LQP02HQ1N5W02E			14				
	LQP02HQ1N5B02L	1.5						
	LQP02HQ1N5B02E							
	LQP02HQ1N5C02L				0.08			
	LQP02HQ1N5C02E							
	LQP02HQ1N6B02L					14		700
	LQP02HQ1N6B02E	1.6						
_	LQP02HQ1N6C02L							
	LQP02HQ1N6C02E						10.7	
	LQP02HQ1N7B02L							
	LQP02HQ1N7B02E	1.7						
	LQP02HQ1N7C02L	-						
	LQP02HQ1N7C02E							
	LQP02HQ1N8B02L	-						
	LQP02HQ1N8B02E LQP02HQ1N8C02L	1.8				13.5		
	LQP02HQ1N8C02E	-	D:±0 15□					
	LQP02HQ1N8C02E LQP02HQ1N9B02L		B:±0.1nH C:+0.2nH				10.2	
	LQP02HQ1N9B02E		C:±0.2nH					
	LQP02HQ1N9B02E LQP02HQ1N9C02L	1.9				12.5		
	LQP02HQ1N9C02E	}						
	LQP02HQ1N9C02E LQP02HQ2N0B02L							
	LQP02HQ2N0B02E LQP02HQ2N0C02L	2.0						
	LQP02HQ2N0C02E							
					0.1	11.5	10.1	
_	LQP02HQ2N1B02L LQP02HQ2N1B02E	-						
					1		1	
	LQP02HQ2N1C02L	2.1						650

Customer	MURATA	Ind	uctance	Q	DC	Self Re Frequ	sonant	Rated
Part Number	Part Number	IIIu		(min)	Resistance	(GF		Current
		(nH)	Tolerance	(111111)	(Ω max)	*Typ.	Min.	(mA)
	LQP02HQ2N2B02L	<u> </u>						
	LQP02HQ2N2B02E	2.2				11.5		500
	LQP02HQ2N2C02L							
	LQP02HQ2N2C02E						9.8	
	LQP02HQ2N3B02L	<u> </u>					3.0	
	LQP02HQ2N3B02E	2.3						450
	LQP02HQ2N3C02L	2.5						430
	LQP02HQ2N3C02E							
	LQP02HQ2N4B02L							
	LQP02HQ2N4B02E	2.4						
	LQP02HQ2N4C02L	2.4						
	LQP02HQ2N4C02E	1				4.4		
	LQP02HQ2N5B02L					11		
	LQP02HQ2N5B02E	1 <u></u>						
	LQP02HQ2N5C02L	2.5					9.5	
	LQP02HQ2N5C02E	1			1			
	LQP02HQ2N6B02L				1			
	LQP02HQ2N6B02E	1						
	LQP02HQ2N6C02L	2.6			0.2			
	LQP02HQ2N6C02E	†						
	LQP02HQ2N7B02L							
	LQP02HQ2N7B02E	1						
	LQP02HQ2N7C02L	2.7						450
	LQP02HQ2N7C02E	1						
	LQP02HQ2N8B02L							
	LQP02HQ2N8B02E	†						
	LQP02HQ2N8C02L	2.8				10.5	8.8	
	LQP02HQ2N8C02E	†	B:±0.1nH					
	LQP02HQ2N9B02L		C:±0.2nH	14				
	LQP02HQ2N9B02E	†	0.10.21111					
	LQP02HQ2N9B02E	2.9						
	LQP02HQ2N9C02E	1						
	LQP02HQ3N0B02L							
	LQP02HQ3N0B02E	1						
	LQP02HQ3N0C02L	3.0						
		1						
	LQP02HQ3N0C02E	1			-			
	LQP02HQ3N1B02L	+		1				
	LQP02HQ3N1B02E	3.1					8.5	
	LQP02HQ3N1C02L	+			1			
	LQP02HQ3N1C02E			1				
	LQP02HQ3N2B02L	+			1			
	LQP02HQ3N2B02E	3.2			0.25			
	LQP02HQ3N2C02L	1						
	LQP02HQ3N2C02E					10		400
	LQP02HQ3N3B02L	+			1			
	LQP02HQ3N3B02E	3.3		1				
	LQP02HQ3N3C02L	1			1			
	LQP02HQ3N3C02E	-			ļ			
	LQP02HQ3N4B02L	4		1				
	LQP02HQ3N4B02E	3.4		1			8.2	
	LQP02HQ3N4C02L	1			1			
	LQP02HQ3N4C02E				0.3			
	LQP02HQ3N5B02L	1		1	0.5			
	LQP02HQ3N5B02E	3.5			1			350
	LQP02HQ3N5C02L] 3.3			1			330
	LQP02HQ3N5C02E							

pec No. JELF243C-002	23A-01						<u>y</u>	P.4/ I
Customer Part Number	MURATA Part Number		uctance	Q (min)	DC Resistance	Self Re Frequ (GH	ency lz)	Rated Current
		(nH)	Tolerance	(111111)	(Ω max)	*Typ.	Min.	(mA)
	LQP02HQ3N6B02L	4						
	LQP02HQ3N6B02E	3.6			0.3			
	LQP02HQ3N6C02L	_			0.0			
	LQP02HQ3N6C02E	<u> </u>						
	LQP02HQ3N7B02L	4						
	LQP02HQ3N7B02E	3.7					8.2	
	LQP02HQ3N7C02L	_						
	LQP02HQ3N7C02E	<u> </u>				9.5		
	LQP02HQ3N8B02L	_						
	LQP02HQ3N8B02E	3.8						
	LQP02HQ3N8C02L	-						
	LQP02HQ3N8C02E							
	LQP02HQ3N9B02L							
	LQP02HQ3N9B02E	3.9	B:±0.1nH	14			7.7	
	LQP02HQ3N9C02L	0.0	C:±0.2nH	17				
	LQP02HQ3N9C02E							
	LQP02HQ4N0B02L							
	LQP02HQ4N0B02E	4.0						
	LQP02HQ4N0C02L	4.0						
	LQP02HQ4N0C02E					9		350
	LQP02HQ4N1B02L					9		350
	LQP02HQ4N1B02E				0.35			
	LQP02HQ4N1C02L	4.1			0.35			
	LQP02HQ4N1C02E						6.9	
	LQP02HQ4N2B02L						0.9	
	LQP02HQ4N2B02E	4.2						
	LQP02HQ4N2C02L	4.2						
	LQP02HQ4N2C02E							
	LQP02HQ4N3H02L							
	LQP02HQ4N3H02E	1						
	LQP02HQ4N3J02L	4.3						
	LQP02HQ4N3J02E							
	LQP02HQ4N7H02L					8		
	LQP02HQ4N7H02E	1						
	LQP02HQ4N7J02L	4.7					6.7	
	LQP02HQ4N7J02E	1						
	LQP02HQ5N1H02L		1					
	LQP02HQ5N1H02E	1						
	LQP02HQ5N1J02L	5.1					6.6	
	LQP02HQ5N1J02E	1						
	LQP02HQ5N6H02L		H:±3%	13				
	LQP02HQ5N6H02E	-	J:±5%					
	LQP02HQ5N6J02L	5.6				7.5	6.1	
	LQP02HQ5N6J02E	1						
	LQP02HQ6N2H02L	+						
	LQP02HQ6N2H02E	1						
	LQP02HQ6N2J02L	6.2			0.4		6.0	300
		+						
	LQP02HQ6N2J02E					7.0		
	LQP02HQ6N8H02L	+						
	LQP02HQ6N8H02E	6.8					5.7	
	LQP02HQ6N8J02L	1						
	LQP02HQ6N8J02E	L		L				

Customer Part Number	MURATA Part Number	Ind	uctance	Q (min)	DC Resistance	Self Re Frequ (GH	ency	Rated Current
		(nH)	Tolerance	(min)	(Ω max)	*Typ.	Min.	(mA)
	LQP02HQ7N5H02L							
	LQP02HQ7N5H02E	7.5					F 0	
	LQP02HQ7N5J02L	7.5					5.6	
	LQP02HQ7N5J02E					0.5		
	LQP02HQ8N2H02L					6.5		
	LQP02HQ8N2H02E				0.5			000
	LQP02HQ8N2J02L	8.2			0.5		5.1	300
	LQP02HQ8N2J02E							
	LQP02HQ9N1H02L							
	LQP02HQ9N1H02E							
		9.1				6.0		
	LQP02HQ9N1J02L							
	LQP02HQ9N1J02E						4.9	
	LQP02HQ10NH02L							
	LQP02HQ10NH02E	10			0.6	5.8		250
	LQP02HQ10NJ02L							
	LQP02HQ10NJ02E							
	LQP02HQ11NH02L				0.8			
	LQP02HQ11NH02E	11		13				
	LQP02HQ11NJ02L	'''	. 1			5.6		
	LQP02HQ11NJ02E							
	LQP02HQ12NH02L					3.0		
	LQP02HQ12NH02E	40			0.00			220
	LQP02HQ12NJ02L	12	H:±3%		0.82			230
	LQP02HQ12NJ02E		J:±5%					
	LQP02HQ13NH02L							
	LQP02HQ13NH02E	13			0.99		4.0	210
	LQP02HQ13NJ02L	13			0.99			210
	LQP02HQ13NJ02E					4.8		
	LQP02HQ15NH02L					1.0		
	LQP02HQ15NH02E	15						
	LQP02HQ15NJ02L							
	LQP02HQ15NJ02E				1.53			170
	LQP02HQ16NH02L							
	LQP02HQ16NH02E	16				4.4		
	LQP02HQ16NJ02L							
	LQP02HQ16NJ02E							
	LQP02HQ18NH02L							
	LQP02HQ18NH02E	18			1.63	4.2	3.7	160
	LQP02HQ18NJ02L							
	LQP02HQ18NJ02E LQP02HQ20NH02L							
	LQP02HQ20NH02E							
	LQP02HQ20NH02E	20						
	LQP02HQ20NJ02E							
	LQP02HQ22NH02L			12	2.26	3.9	3.0	140
	LQP02HQ22NH02E							
	LQP02HQ22NJ02L	22						
	LQP02HQ22NJ02E							

^{*} Typical value is actual performance.

4. Testing Conditions

《Unless otherwise specified》

Temperature : Ordinary Temperature / 15°C to 35°C

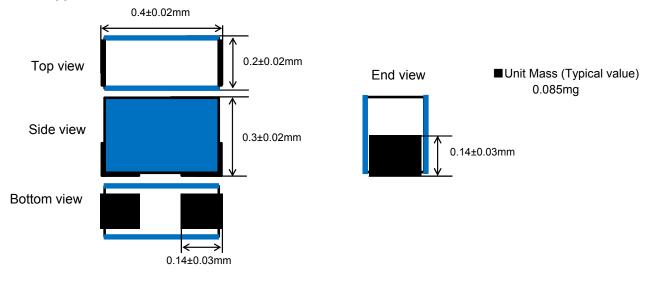
Humidity: Ordinary Humidity / 25%(RH) to 85 %(RH)

《In case of doubt》

Temperature : 20°C ± 2°C

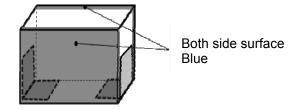
Humidity : 60%(RH) to 70 %(RH)
Atmospheric Pressure : 86kPa to 106 kPa

5. Appearance and Dimensions



6. Marking

Side surface identification marking: Blue





7. Electrical Performance

No.	Item	Specification	Test Method
7.1	Inductance	Inductance shall meet item 3.	Measuring Equipment: KEYSIGHT E4991A or equivalent Measuring Frequency:500MHz Measuring Condition: Test signal level / about 0dBm Electrical length / 27.3mm Measuring Fixture: KEYSIGHT 16196D Insert Chip coil in the hole in order that the polarity marking is at the top of the side surface. Contact coil with each terminal by adding the weigh cover. See diagram below.
7.2	Q	Q shall meet item 3.	Make close contact of the outer electrode of a product with the lower electrode like above
			to avoid dispersion of measurement. Chip coil placement hole: φ 0.36mm Measuring Method:See P.16. <electrical inductance="" method="" of="" performance:measuring="" q=""></electrical>
7.3	DC Resistance	DC Resistance shall meet item 3.	Measuring Equipment:Digital multi meter
7.4	Self Resonant Frequency(S.R.F)	S.R.F shall meet item 3.	Measuring Equipment: KEYSIGHT N5230A or equivalent
7.5	Rated	Self temperature rise shall be	The rated current is applied.
	Current	limited to 25°C max.	



8.Mechanical Performance

No.	Item	Specification	Test Method
8.1	Shear Test	Chip coil shall not be damaged	Substrate:Glass-epoxy substrate
		after tested as test method.	Land
			Land
			0.16
			<u> </u>
			(in mm)
			0.56
			Force:1N
			Hold Duration:5 s±1 s
			Applied Direction: Parallel to PCB
			Chip coil —
			Substrate
8.2	Bending Test	-	Substrate:Glass-epoxy substrate
0.2	Dending Test		(100mm × 40mm × 0.8mm)
			Speed of Applying Force:1mm /s
			Deflection:1mm
			Hold Duration:30 s
			Pressure jig
			R340 F
			Deflection
			45 45 Product (in mm)
8.3	Vibration	Appearance:No damage	Substrate: Glass-epoxy substrate
		Inductance Change: within ±10%	Oscillation Frequency:
			10Hz to 2000Hz to 10Hz for 20 min
			Total amplitude 1.5 mm or Acceleration
			amplitude 196 m/s ² whichever is smaller.
			Testing Time:A period of 2h in each of 3 mutually perpendicular directions.
8.4	Solderability	The electrode shall be at least 90%	Flux: Ethanol solution of rosin 25(wt)%
0.4	Coluctability	covered with new solder coating.	(Immersed for 5s to 10s)
		Covered with new solder coating.	Solder:Sn-3.0Ag-0.5Cu
			Pre-Heating:150°C±10°C / 60s to 90s
			Solder Temperature:240°C±5°C
			Immersion Time:3s±1s
8.5	Resistance to	Appearance:No damage	Flux: Ethanol solution of rosin 25(wt)%
	Soldering Heat	Inductance Change: within ±10%	(Immersed for 5s to 10s)
			Solder:Sn-3.0Ag-0.5Cu
			Pre-Heating:150°C±10°C / 60s to 90s
			Solder Temperature:260°C±5°C
			Immersion Time:5s±1s
			Then measured after exposure in the room
			condition for 24h±2h.



9.Environmental Performance

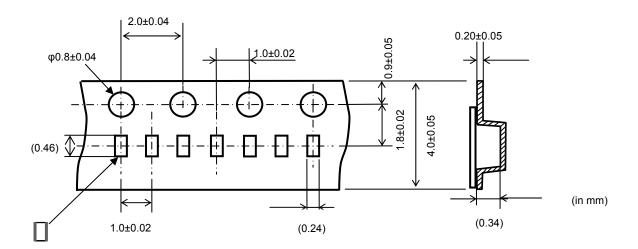
It shall be soldered on the substrate.

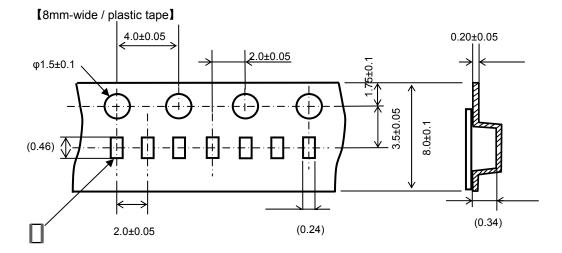
No.	Item	Specification	Test Method
9.1	Heat Resistance	Appearance:No damage	Substrate: Glass-epoxy substrate
		Inductance Change: within ±10%	Temperature:125°C±2°C
			Time:1000h (+48h,-0h)
			Then measured after exposure in the
			room condition for 24h±2h.
9.2	Cold Resistance		Substrate: Glass-epoxy substrate
			Temperature:-55°C±3°C
			Time:1000 h (+48h,-0h)
			Then measured after exposure in the
			room condition for 24h±2h.
9.3	Humidity		Substrate: Glass-epoxy substrate
			Temperature:40°C±2°C
			Humidity:90%(RH) to 95%(RH)
			Time:1000 h(+48h,-0h)
			Then measured after exposure in the
			room condition for 24h±2h.
9.4	Temperature		Substrate: Glass-epoxy substrate
	Cycle		1 cycle:
			1 step:-55°C±2°C / 30min±3 min
			2 step:Ordinary temp. / 10~15 min
			3 step:125°C±2°C / 30±3 min
			4 step: Ordinary temp. / 10~15 min
			Total of 10 cycles
			Then measured after exposure in the
			room condition for 24h±2h.

10. Specification of Packaging

10.1 Appearance and Dimensions

[4mm-wide / plastic tape]





Dimension of the Cavity is measured at the bottom side.

10.2 Specification of Taping

[4mm-wide / plastic tape]

- (1) Packing quantity (standard quantity)
 - 30,000 pcs. / reel
- (2) Packing Method

Products shall be packed in the each embossed cavity of plastic tape and sealed by cover tape.

(3) Sprocket hole

The sprocket holes are to the right as the tape is pulled toward the user.

(4) Spliced point

Plastic tape and Cover tape has no spliced point.

(5) Missing components number

Missing components number within 0.1 % of the number per reel or 1 pc. , whichever is greater, and are not continuous. The Specified quantity per reel is kept.

[8 mm-wide / plastic tape]

- (1) Packing quantity (standard quantity)
 - 15,000 pcs. / reel
- (2) Packing Method

Products shall be packed in the each embossed cavity of plastic tape and sealed by cover tape.

(3) Sprocket hole

The sprocket holes are to the right as the tape is pulled toward the user.

(4) Spliced point

Plastic tape and Cover tape has no spliced point.

(5) Missing components number

Missing components number within 0.1 % of the number per reel or 1 pc., whichever is greater, and are not continuous. The Specified quantity per reel is kept.

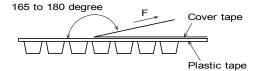


10.3 Pull Strength

Cover tape	5N min

10.4 Peeling off force of cover tape

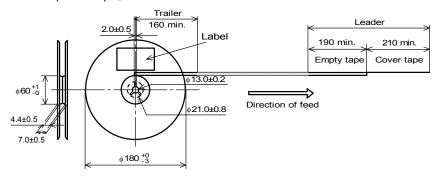
Speed of Peeling off	300mm/min
Dealing off force	0.1N to 0.6N
Peeling off force	(minimum value is typical)



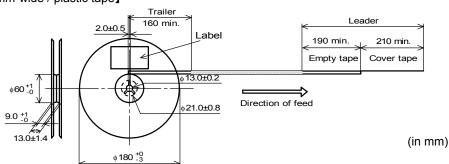
10.5 Dimensions of Leader-tape, Trailer and Reel

There shall be leader-tape (top tape and empty tape) and trailer-tape (empty tape) as follows.

[4mm-wide / plastic tape]



[8mm-wide / plastic tape]



10.6 Marking for reel

Customer part number, MURATA part number, Inspection number(*1), RoHS Marking(*2), Quantity etc \cdots

*1) < Expression of Inspection No.>

 $\frac{\square\square}{(1)} \quad \frac{OOOO}{(2)} \stackrel{\times\times\times}{(3)}$

- (1) Factory Code
- (2) Date First digit : Year / Last digit of year

Second digit : Month / Jan. to Sep. \rightarrow 1 to 9, Oct. to Dec. \rightarrow O,N,D

Third, Fourth digit: Day

(3) Serial No.

*2) <Expression of RoHS Marking >

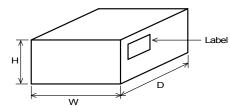
ROHS
$$-\frac{Y}{(1)}(\underline{\Delta})$$

- (1) RoHS regulation conformity parts.
- (2) MURATA classification number

10.7 Marking for Outside package (corrugated paper box)

Customer name, Purchasing order number, Customer part number, MURATA part number, RoHS Marking (*2), Quantity, etc ···

10.8 Specification of Outer Case



	Outer	Case Dim (mm)	ensions	Standard Reel Quantity in Outer Case (Reel)
Ī	W	D	Н	in Outer Case (Reei)
ſ	186	186	93	5(8mm-wide / plastic tape)
L				10(4mm-wide / plastic tape)

* Above Outer Case size is typical. It depends on a quantity of an order.

11. 🕂 Caution

Limitation of Applications

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or property.

- (1) Aircraft equipment
- (2) Aerospace equipment
- (3) Undersea equipment
- (4) Power plant control equipment
- (5) Medical equipment
- (6) Transportation equipment (vehicles, trains, ships, etc.)
- (7) Traffic signal equipment
- (8) Disaster prevention / crime prevention equipment
- (9) Data-processing equipment
- (10) Applications of similar complexity and /or reliability requirements to the applications listed in the above

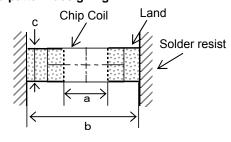
12. Notice

Products can only be soldered with reflow.

This product is designed for solder mounting.

Please consult us in advance for applying other mounting method such as conductive adhesive.

12.1 Land pattern designing



а	0.20
b	0.56
С	0.16
	(in mm)

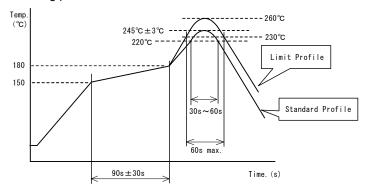
12.2 Flux, Solder

- · Use rosin-based flux.
- Don't use highly acidic flux with halide content exceeding 0.2(wt)% (chlorine conversion value). Don't use water-soluble flux.
- · Use Sn-3.0Ag-0.5Cu solder.
- Standard thickness of solder paste : 50 μ m ~65 μ m.



12.3 Reflow soldering conditions

- Pre-heating should be in such a way that the temperature difference between solder and
 product surface is limited to 150°C max. Cooling into solvent after soldering also should be
 in such a way that the temperature difference is limited to 100°C max.
 Insufficient pre-heating may cause cracks on the product, resulting in the deterioration of
 products quality.
- Standard soldering profile and the limit soldering profile is as follows.
 The excessive limit soldering conditions may cause leaching of the electrode and / or resulting in the deterioration of product quality.
- · Reflow soldering profile



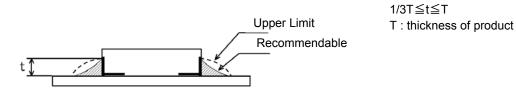
	Standard Profile	Limit Profile
Pre-heating	150°C~180°C 、90s±30s	
Heating	above 220°C, 30s∼60s	above 230°C, 60s max.
Peak temperature	245°C±3°C	260°C,10s
Cycle of reflow	2 times	2 times

12.4 Reworking with soldering iron

Reworking with soldering iron is disapproved.

12.5 Solder Volume

· Solder shall be used not to be exceeded the upper limits as shown below.



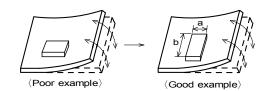
Accordingly increasing the solder volume, the mechanical stress to Chip is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance and become easy to tilt.

12.6 Attention regarding P.C.B. bending

The following shall be considered when designing and laying out P.C.B.'s.

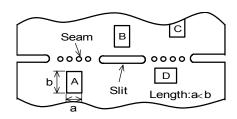
(1) P.C.B. shall be designed so that products are not subject to the mechanical stress due to warping the board.

[Products direction]



Products shall be located in the sideways direction (Length:a < b) to the mechanical stress.

(2) Products location on P.C.B. separation



Products (A,B,C,D) shall be located carefully so that products are not subject to the mechanical stress due to warping the board. Because they may be subjected the mechanical stress in order of $A>C>B \equiv D$.

12.7 Cleaning Conditions

Products shall be cleaned on the following conditions.

- (1) Cleaning temperature shall be limited to 60°C max.(40°C max for IPA)
- (2) Ultrasonic cleaning shall comply with the following conditions with avoiding the resonance phenomenon at the mounted products and P.C.B.

Power: 20 W / I max. Frequency: 28kHz to 40kHz Time: 5 min max.

- (3) Cleaner
 - 1. Alcohol type cleaner Isopropyl alcohol (IPA)
 - 2. Aqueous agent PINE ALPHA ST-100S
- (4) There shall be no residual flux and residual cleaner after cleaning.

 In the case of using aqueous agent, products shall be dried completely after rinse with de-ionized water in order to remove the cleaner.
- (5) Other cleaning Please contact us.

12.8 Resin coating

When products are coated with resin, please contact us in advance.

12.9 Handling of a substrate

(1)There is a possibility of chip cracking caused by PCBexpansion/contraction with heat, because stress on a chip is different depending on PCB material and structure.

When the thermal expansion coefficient greatly differs between the board used for mounting and the chip, it will cause cracking of the chip due to the thermal expansion and contraction.

The chip is assumed to be mounted on the PCB of glass-epoxy material, and we don't test with other PCB material which has different thermal expansion coefficient from Glass-epoxy.

When other PCB materials are considered, please be sure to evaluate by yourself.



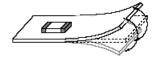
(2)After mounting products on a substrate, do not apply any stress to the product caused by bending or twisting to the substrate when cropping the substrate, inserting and removing a connector from the substrate or tightening screw to the substrate.

Excessive mechanical stress may cause cracking in the product.

In case of the mounting on flexible PCB, there is a possibility of chip cracking caused by mechanical stress even from small bending or twisting.

When the flexible PCB is considered, please be sure to evaluate by yourself.

Bending Twisting





12.10 Storage and Handing Requirements

(1) Storage period

Use the products within 12 months after deliverd. Solderability should be checked if this period is exceeded.

(2) Storage conditions

• Products should be stored in the warehouse on the following conditions.

Temperature : -10°C ~ 40°C

Humidity : 30% to 70% relative humidity No rapid change on temperature and humidity.

- Products should not be stored on bulk packaging condition to prevent the chipping of the core and the breaking of winding wire caused by the collision between the products.
- Products should be stored on the palette for the prevention of the influence from humidity, dust and so on.
- Products should be stored in the warehouse without heat shock, vibration, direct sunlight and so on.
- (3) Handling Condition

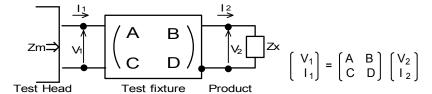
Care should be taken when transporting or handling product to avoid excessive vibration or mechanical shock.

13./\!\ Note

- (1)Please make sure that your product has been evaluated in view of your specifications with our product being mounted to your product.
- (2)You are requested not to use our product deviating from the reference specifications.
- (3)The contents of this reference specification are subject to change without advance notice. Please approve our product specifications or transact the approval sheet for product specifications before ordering.

-<Electrical Performance:Measuring Method of Inductance/Q>-

(1) Residual elements and stray elements of test fixture can be described by F-parameter shown in following.



(2) The impedance of chip coil Zx and measured value Zm can be described by input/output current/voltage.

$$Zm = \frac{V_1}{I_1}$$
 $Zx = \frac{V_2}{I_2}$

(3) Thus, the relation between Zx and Zm is following;

$$Zx = \alpha \frac{Zm - \beta}{1 - Zm \Gamma}$$
 where, $\alpha = D / A = 1$
 $\beta = B / D = Zsm - (1 - Yom Zsm)Zss$
 $\Gamma = C / A = Yom$

Zsm:measured impedance of short chip Zss:residual impedance of short chip (0.110nH) Yom:measured admittance when opening the fixture

(4) Lx and Qx shall be calculated with the following equation.

$$x = \frac{Im(Zx)}{2 \pi f}$$
, $Qx = \frac{Im(Zx)}{Re(Zx)}$ Lx:Inductance of chip coil
 $Qx:Q$ of chip coil
 f :Measuring frequency